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Particle characterization of particulate systems — Vocabulary

Caractérisation des particules dans les systèmes particulaires — Vocabulaire

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

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The committee responsible for this document is ISO/TC 24, Particle characterization including sieving, Subcommittee SC 4, Particle characterization. ISO 26824:2013 https://standards.iteh.ai/catalog/standards/sist/16e206d9-460b-49d6-8f8c-

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Introduction

Since 1995, some 20 International Standards have been published by ISO/TC 24/SC 4, and at the time of publication of this International Standard, about 12 projects were under development, not to mention revisions of existing standards. Therefore it was not before time that terms defined in standards that were relevant for others be collected and adjusted into a single, uniform vocabulary.

In particular, the interdisciplinary application fields of particle and particulate systems characterization — from mining and construction, the pharmaceutical and food industries, medicine and life sciences, the chemical industry, microelectronics and nanotechnology — need clear and unambiguous terminology. The development of international trade, not only in measurement devices for particle characterization, but also of process equipment for the production and treatment of particulate systems, underlines the need for comparability of quality and performance parameters, as well as in international health, safety and environmental protection regulations.

The structuring and presentation rules applied to the terminological entries, based on a clause structure, represents the methods of results presentation and the analysis methods, and starts with general terms in each clause.

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Particle characterization of particulate systems — Vocabulary

Scope

This International Standard establishes a vocabulary of terms and definitions relevant to the particle characterization of particulate systems. It covers such fields as the representation of results of particle size analysis, the descriptive and quantitative representation of particle shape and morphology, sample preparation, specific surface area and porosity characterization and measurement methods including sedimentation, classification, acoustic methods, laser diffraction, dynamic light scattering, single particle light interaction methods, differential electrical mobility analysis and image analysis, in a size scale from nanometre to millimetre.

1 General terms, representation of particle size and classification analysis

1.1

particle

minute piece of matter with defined physical boundaries

Note 1 to entry: A physical boundary can also be described as an interface. W

Note 2 to entry: A particle can move asaunit ards.iteh.ai)

Note 3 to entry: This general particle definition applies to nano-objects.

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[SOURCE: ISO 14644**+6:2007/2102; modified** The subject field (senerals" has been removed and the notes added.] 1d16469e6222/iso-26824-2013

1.2

agglomerate

collection of weakly or medium strongly bound particles where the resulting external surface area is similar to the sum of the surface areas of the individual components

Note 1 to entry: The forces holding an agglomerate together are weak forces, for example van der Waals forces or simple physical entanglement.

Note 2 to entry: Agglomerates are also termed secondary particles and the original source particles are termed primary particles.

[SOURCE: ISO/TS 27687:2008, 3.2, modified.]

1.3

aggregate

particle comprising strongly bonded or fused particles where the resulting external surface area is significantly smaller than the sum of surface areas of the individual components

Note 1 to entry: The forces holding an aggregate together are strong forces, for example covalent bonds, or those resulting from sintering or complex physical entanglement, or otherwise combined former primary particles.

Note 2 to entry: Aggregates are also termed secondary particles and the original source particles are termed primary particles.

[SOURCE: ISO/TS 27687:2008, 3.3, modified.]

primary particle

original source particle of agglomerates or aggregates or mixtures of the two

Note 1 to entry: Constituent particles of agglomerates or aggregates at a certain actual state may be primary particles, but often the constituents are aggregates.

Note 2 to entry: Agglomerates and aggregates are also termed secondary particles.

1.5 particle size

۸ d

X

d

linear dimension of a particle determined by a specified measurement method and under specified measurement conditions

Note 1 to entry: Different methods of analysis are based on the measurement of different physical properties. Independent of the particle property actually measured, the particle size is reported as a linear dimension, e.g. as the equivalent spherical diameter.

Note 2 to entry: Examples of size descriptors are those based at the opening of a sieve or a statistical diameter, e.g. the Feret diameter, measured by image analysis.

Note 3 to entry: In ISO 9276-1:1998, the symbol *x* is used to denote the particle size. However, it is recognized that the symbol *d* is also widely used to designate these values. Therefore the symbol *x* may be replaced by *d*.

[SOURCE: ISO 9276-1:1998, 4.2, modified.] ANDARD PREVIEW

1.6 equivalent spherical diameter

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diameter of a sphere having the same physical properties as the particle in the measurement

Note 1 to entry: Physical properties are for instance the same settling velocity or electrolyte solution displacing volume or projection area under a microscope.

Note 2 to entry: The physical property to which the equivalent diameter refers shall be indicated using a suitable subscript, for example x_S for equivalent surface area diameter or x_V for equivalent volume diameter.

[SOURCE: ISO 9276-1:1998, 4.2, modified.]

1.7 type of quantity

specification of the quantity of a distribution, a cumulative or a density measure

Note 1 to entry: The type is indicated by the general subscript, *r*, or by the appropriate value of *r* as follows:

— number: *r* = 0

— length: r = 1

— area: *r* = 2

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— volume or mass: r = 3
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[SOURCE: ISO 9276-1:1998, 4.3, modified.]
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1.8 cumulative distribution

 $Q_{\rm r}(x)$

distribution of the fraction of material smaller (undersize) than given particle sizes

Note 1 to entry: If the cumulative distribution, $Q_r(x)$, is calculated from histogram data, only individual points $Q_{r,i} = Q_r(x_i)$ are obtained. Each individual point of the distribution, $Q_r(x_i)$, defines the relative amount of particles smaller than or equal to x_i . The continuous curve is calculated by suitable interpolation algorithms. The normalized cumulative distribution extends between 0 and 1, i.e. 0 and 100 %.

$$Q_{\mathbf{r},i} = \sum_{\nu=1}^{i} \Delta Q_{\mathbf{r},\nu} = \sum_{\nu=1}^{i} \overline{q}_{\mathbf{r},\nu} \Delta x_{\nu} \quad \text{with } 1 \le \nu \le i \le n$$

where

- *i* (subscript) number of the size class with upper limit *x_i*
- ν (integer, see subscript *i*)
- *n* total number of size classes

 $Q_{r,\nu}$ relative amount of particles in size class with upper limit x_{ν}

Note 2 to entry: When plotted on a graph paper with a logarithmic abscissa the cumulative values, $Q_{r,i}$, i.e. the ordinates of a cumulative distribution, do not change. However, the course of the cumulative distribution curve changes but the relative amounts smaller than a certain particle size remain the same. Therefore, the following formula holds:

 $Q_{\mathrm{r}}(x) = Q_{\mathrm{r}}(\ln x)$

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Note 3 to entry: The cumulative oversize distribution is given by $1^9-6_r(x)$.

[SOURCE: ISO 9276-1:1998, 5.2, modified.]

1.9 distrib

distribution density

 $q_r(x)$ distribution of the fraction of material in a size class, divided by the width of that class

Note 1 to entry: Under the presupposition that the cumulative distribution, $Q_r(x)$, is differentiable, the continuous distribution density, $q_r(x)$, is obtained from

$$q_{\rm r}(x) = \frac{dQ_{\rm r}(x)}{dx}$$

Conversely, the cumulative distribution, $Q_r(x)$, is obtained from the distribution density, $q_r(x)$, by integration:

$$Q_{\rm r}(x_{\rm i}) = \int_{x_{\rm min}}^{x_{\rm i}} q_{\rm r}(x) dx$$

Note 2 to entry: Differential distribution is also named in statistics "density of a probability or frequency".

Note 3 to entry: The term "density distribution" can be misunderstood in the context of sedimentation methods with different materials and will be not used in standards developed by ISO/TC24/SC 4.

[SOURCE: ISO 9276-1:1998, 5.3, modified — Notes 2 and 3 have been added.]

1.10 distribution density on a logarithmic abscissa $q_r^*(x)$

distribution density, transformed for a logarithmic abscissa

Note 1 to entry: The density values of a histogram, $\overline{q}_{r,i}^* = \overline{q}_r^*(x_{i-1},x_i)$, shall be recalculated using the following formula which indicates that the corresponding areas underneath the distribution density curve remain constant. In particular, the total area is equal to 1 or 100 %, independent of any transformation of the abscissa.

 $\overline{q}_{r}^{*}(\xi_{i-1},\xi_{i})\Delta\xi_{i}=\overline{q}_{r}(x_{i-1},x_{i})\Delta x_{i}$

where ξ is any function of x.

Thus the following transformation shall be carried out to obtain the distribution density with a logarithmic abscissa:

 $q_{r}^{*}(x_{i}) = q_{r,i} \cdot x_{i} \text{ or } \overline{q}_{r}^{*}(\ln x_{i-1}, \ln x_{i}) = \frac{\overline{q}_{r}(x_{i-1}, x_{i})\Delta x_{i}}{\ln x_{i} - \ln x_{i-1}} = \frac{\overline{q}_{r,i}\Delta x_{i}}{\ln(x_{i}/x_{i-1})} = \frac{\Delta Q_{r,i}}{\ln(x_{i}/x_{i-1})}$

Note 2 to entry: This formula also holds if the natural logarithm is replaced by the logarithm to base 10.

[SOURCE: ISO 9276-1:1998, 6.2, modified.]

1.11 histogram

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 $\bar{q}_{r}(x)$ normalized histogram, $\bar{q}_{r}(x)$, of a *distribution density* (1.9), $q_{r}(x)$, comprising a successive series of rectangular columns, the area of each of which represents the relative quantity $\Delta Q_{r,i}(x)$, where

$$\Delta Q_{r,i} = \Delta Q_r(x_{i-1}, x_i) = \frac{q_r(x_{i-1}, x_i)\Delta x}{q_r(x_{i-1}, x_i)\Delta x} \text{ or } q_{r,i} = \frac{\Delta Q_r(x_{i-1}, x_i)}{\Delta x_i} = \frac{\Delta Q_r(x_{i-1}, x_i)}{\Delta x$$

Note 1 to entry: The sum of all the relative quantities, $\Delta Q_{r,l}$ forms the area beneath the histogram $q_r(x)$, normalized to 100 % or 1 (condition of normalization). Therefore, the following formula holds:

$$\sum_{i=1}^{n} \Delta Q_{\mathrm{r},i} = \sum_{i=1}^{n} \bar{q}_{\mathrm{r},i} \Delta x_{i} = 1 = 100 \%$$

[SOURCE: ISO 9276-1:1998, 5.1, modified.]

1.12

concentration distribution density

distribution of the concentration of material in a size class, divided by the width of that class

Note 1 to entry: In aerosol measurement, e. g. the distribution density of the particle number concentration, is represented as a function of the particle size.

Note 2 to entry: The concentration distribution density can be calculated from the distribution density function of the particle size by multiplication with the overall sizes measured concentration.

1.13

analytical cut size

xa

cut size with the coarse and the fine material containing equal quantities of misplaced material

Note 1 to entry: Since the relative mass of the fine material as determined by the classification process, is taken to be equal to the relative mass of the undersize material in the feed, that is $Q_{3,s}(x)$, an analytical cut size x corresponding to this definition has to be found.

[SOURCE: ISO 9276-4:2001, 4.3.2, modified.]

1.14 equiprobable cut size

x_e

cut size, which represents the median of the grade efficiency curve $T(x_e) = 0.5$

Note 1 to entry: The weighted distribution density curves of the fine and the coarse fraction intersect at the equiprobable cut size x_e . Independently from other particle sizes, particles of this size have the equal probability to be classified into the fine and into the coarse fraction.

[SOURCE: ISO 9276-4:2001, 4.3.1, modified.]

1.15 grade efficiency

Tromp's curve

T(x)

representation, for a certain particle size x, of the ratio of the amount of material present in the coarse material to the amount of the same size initially present in the feed material

Note 1 to entry: In the dust collection field, this efficiency is called "partial separation efficiency".

[SOURCE: ISO 9276-4:2001, 4.4, modified — The note has been added.]

2 Sedimentation analysis iTeh STANDARD PREVIEW

2.1

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effective particle density particle mass divided by the volume of liquid it displaces

[SOURCE: ISO 13317-1:2001, 3.1.7, modified.] https://standards.iteh.a/catalog/standards/sist/16e206d9-460b-49d6-8f8c-1d16469e6222/iso-26824-2013

2.2

true particle density particle mass divided by the volume it would occupy excluding all pores, closed or open, and surface fissures

Note 1 to entry: True particle density is sometimes referred to as the absolute particle density.

[SOURCE: ISO 13317-1:2001, 3.1.8.]

2.3

oversize

portion of the charge which has not passed through the apertures of a stated sieve

[SOURCE: ISO 13317-1:2001, 3.1.5.]

2.4

pycnometry

method wherein particle density is obtained from the measured mass of sample with a given calibrated volume

2.5

Stokes diameter

equivalent spherical diameter of the particle that has the same density and terminal settling velocity as the real particle in the same liquid under creeping flow conditions

[SOURCE: ISO 13317-1:2001, 3.1.2.]

terminal settling velocity

velocity of a particle through a still liquid at which the force due to gravity on the particle is balanced by the drag exerted by the liquid

[SOURCE: ISO 13317-1:2001, 3.1.1.]

2.7

undersize

portion of the charge which has passed through the apertures of a stated sieve

[SOURCE: ISO 13317-1:2001, 3.1.6.]

Pore size distribution, porosity and surface area analysis 3

3.1

molecular cross-sectional area

molecular area of the adsorbate, i.e. the area occupied by an adsorbate molecule in the complete monolayer

[SOURCE: ISO 9277:2010, 3.10.]

3.2

free space

volume of the sample holder not occupied by the sample

Note 1 to entry: Also called head space, dead space, or dead volume. PREVIEW

[SOURCE: ISO 9277:2010, 3.14.]

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3.3

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specific surface area 824-2013

[SOURCE: ISO 9277:2010, 3.15.]

3.4

apparent density

mass of a powder divided by the total volume of the sample, including closed and inaccessible pores, as determined by the stated method

[SOURCE: ISO 15901-1:2005, 3.23.]

3.5

bulk density

powder density under defined conditions

[SOURCE: ISO 15901-1:2005, 3.1.]

3.6

blind pore

dead end pore open pore having a single connection with an external surface

[SOURCE: ISO 15901-2:2006, 3.6.]

3.7

closed pore

cavity not connected to the external surface

[SOURCE: ISO 15901-1:2005, 3.3.]

3.8 contact angle angle that a non-wetting liquid makes with a solid material

[SOURCE: ISO 15901-1:2005, 4.4.]

3.9

external surface area

area of external surface including roughness but outside pores

[SOURCE: ISO 15901-1:2005, 3.5.]

3.10 ink bottle pore narrow necked open pore

[SOURCE: ISO 15901-1:2005, 3.3.]

3.11

interconnected pore pore which communicates with one or more other pores

[SOURCE: ISO 15901-1:2005, 3.7.]

3.12 internal surface area area of internal pore wallsch STANDARD PREVIEW

[SOURCE: ISO 15901-1:2005, 3.8.(standards.iteh.ai)

3.13

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intraparticle porosity ratio of the volume of open pores internal to the particle to the total volume occupied by the solid

[SOURCE: ISO 15901-1:2005, 3.9.]

3.14

interparticle porosity

ratio of the volume of space between particles in a powder to the apparent volume of the particles or powder

[SOURCE: ISO 15901-1:2005, 3.10.]

3.15

macropore pore of internal width greater than 50 nm

[SOURCE: ISO 15901-1:2005, 3.11.]

3.16

mesopore

pore of internal width between 2 nm and 50 nm

[SOURCE: ISO 15901-1:2005, 3.12.]

3.17

micropore

pore of internal width less than 2 nm which is accessible for a molecule to be adsorbed

[SOURCE: ISO 15901-1:2005, 3.13.]

open pore

cavity or channel with access to an external surface

[SOURCE: ISO 15901-1:2005, 3.14.]

3.19

open porosity

ratio of the volume of open pores and voids to the total volume occupied by the solid

[SOURCE: ISO 15901-1:2005, 3.15.]

3.20

pore size

pore width, for example, the diameter of a cylindrical pore or the distance between the opposite walls of a slit

Note 1 to entry: One of the methods to determine pore sizes is by mercury porosimetry.

[SOURCE: ISO 15901-1:2005, 3.16.]

3.21

pore volume

porosimeter

volume of pores determined by stated method

[SOURCE: ISO 15901-1:2005, 3.17.]

3.22

3.23

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instrument for measuring porosity and poresize distributionen.ai)

[SOURCE: ISO 15901-1:2005, 3.18.]

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porosimetry

methods for the estimation of porosity and pore size distribution

[SOURCE: ISO 15901-1:2005, 3.19.]

3.24

porosity

ratio of total pore volume to apparent volume of particle or powder

[SOURCE: ISO 15901-1:2005, 3.20.]

3.25

porous solid

solid with cavities or channels which are deeper than they are wide

[SOURCE: ISO 15901-1:2005, 3.21.]

3.26

powder density

mass of a powder divided by its apparent volume, which is taken to be the total volume of the solid material, open and closed pores and interstices

[SOURCE: ISO 15901-1:2005, 3.24.]

3.27

skeleton density

mass of a powder divided by the total volume of the sample, including closed pores but excluding open pores $\$

[SOURCE: ISO 15901-1:2005, 3.22.]

surface area

extent of available surface area as determined by given method under stated conditions

[SOURCE: ISO 15901-1:2005, 3.25.]

3.29

surface tension

force required to separate a film of liquid from either a solid material or a film of the same liquid

[SOURCE: ISO 15901-1:2005, 3.26.]

3.30

through pore

pore which passes all the way through the sample

[SOURCE: ISO 15901-1:2005, 3.27.]

3.31

total porosity

ratio of the volume of void plus the volume of open and closed pores to the total volume occupied by the solid and the volume of void plus pores, e.g. apparent solid volume

[SOURCE: ISO 15901-1:2005, 3.28.]

3.32 true density **iTeh STANDARD PREVIEW**

mass of the particle divided by its volume, excluding open and closed pores (standards.iten.ai)

[SOURCE: ISO 15901-1:2005, 3.29.]

3.33 ISO 26824:2013 void https://standards.iteh.ai/catalog/standards/sist/16e206d9-460b-49d6-8f8cspace between particles, i.e. an interparticle pore

[SOURCE: ISO 15901-1:2005, 3.30.]

3.34 adsorbate adsorbed gas

[SOURCE: ISO 15901-2:2006, 3.1.]

3.35

amount adsorbed

па

number of moles of gas adsorbed at a given pressure p and temperature T[SOURCE: ISO 15901-2:2006, 3.2.]

3.36 adsorbent

solid material on which adsorption occurs

[SOURCE: ISO 15901-2:2006, 3.3.]

3.37

adsorption

enrichment of the adsorptive gas at the external and accessible internal surfaces of a solid material

[SOURCE: ISO 15901-2:2006, 3.4.]